

**Search Notes**

Application/Control No.

10/829,418

Examiner

Yevgeny Valenrod

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

1621

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC search, see transcript	7/10/2006	YV
STN structure/text search, see transcript	7/12/2006	YV
Inventor search	7/13/2006	YV
564/34, 35, 38, 44, 45 +text search, See transcript	7/13/2006	YV